

ATTY. DKT. 28951.5523

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of  
Yasuyuki MAEDA et al  
Serial No. (new - based on PCT/JP2006/310365)  
Int'l Filing Date: May 24, 2006  
For: PART POSITIONING DEVICE

INFORMATION DISCLOSURE STATEMENT

Customer Window  
Commissioner for Patents  
U.S. Patent & Trademark Office  
Randolph Building  
401 Dulany Street  
Alexandria, VA 22314

Sir:

Pursuant to 37 C.F.R. 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449. The listed references include those cited in the International Search Report, copy attached. A copy of the listed foreign references is submitted herewith.

The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 C.F.R. 1.104(a) and 1.106(b) concerning the PTO duty to consider and use any such information. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that these references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

Respectfully submitted,



Roger W. Parkhurst  
Registration No. 25,177

STEPTOE & JOHNSON LLP  
1330 Connecticut Ave., NW  
Washington, D.C. 20036-1795

Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 28951.5523	Application No. New
<b>Information Disclosure Statement          by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant <p style="text-align: center;">Yasuyuki MAEDA et al</p>	
		Filing Date <p style="text-align: center;">Herewith</p>	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,483,391	1/1996	Gweon et al	360	69	
	AB	4,384,334	5/1983	Tateishi et al	364	481	
	AC						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AD	57-29359	6/1982	Japan				X
	AE	08-14865	1/1996	Japan			Abstract	
	AF	59-33658	2/1984	Japan			Abstract	
	AG	62-5700	1/1987	Japan				X
	AH	61-57336	4/1986	Japan				X
	AI	08-201017	8/1996	Japan			Abstract	
	AJ	0 625 691	12/2998	Europe				
	AK	55-148495	11/1980	Japan			Abstract	
	AL							
	AM							
	AN							
	AO							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AP	
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.